

Application/Control No.	Applicant(s)/Patent under Reexamination	-
10/634,843	MARUYAMA ET AL.	
Examiner	Art Unit	
David Phantana-angkool	2179	

SEARCHED				
Class	Subclass	Date	Examiner	
715	783	3/8/2007	DP	
715	781	3/8/2007	. DP	
715	779	3/8/2007	DP	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH N (INCLUDING SEAR)
	DATE	EXMR
EAST -(see attached)	3/8/2007	DP
PLUS	3/3/2007	DP
Inventor Name Search	3/3/2007	DP
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